

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST
CERTIFICATES FOR ELECTRICAL EQUIPMENT
(IECEE) CB SCHEME

SYSTEME CEI D'ACCEPTATION MUTUELLE DE
CERTIFICATS D'ESSAIS DES EQUIPEMENTS
ELECTRIQUES (IECEE) METHODE OC

CB TEST CERTIFICATE

CERTIFICAT D'ESSAI OC

Product
Produit

Scanner

Name and address of the applicant
Nom et adresse du demandeur

Global Scanning A/S
SVANEVANG 2
ALLEROED, 3450 Denmark

Name and address of the manufacturer
Nom et adresse du fabricant

Global Scanning A/S
SVANEVANG 2
ALLEROED, 3450 Denmark

Name and address of the factory
Nom et adresse de l'usine

Global Scanning A/S
GRAESHOLMEVEJ 57
SVENDBORG, 5700 Denmark

*Note: When more than one factory, please report on page 2
Note: Lorsque il y plus d'une usine, veuillez utiliser la 2^{ème} page*

Additional Information on page 2
19 Vdc, 2A (optional)

Ratings and principal characteristics
Valeurs nominales et caractéristiques principales

Contex

Trademark (if any)
Marque de fabrique (si elle existe)
Type of Manufacturer's Testing Laboratories used
Type de programme du laboratoire d'essais
constructeur

TA53D, TB53D, TL53D, TM53D

Model / Type Ref.
Ref. De type

Additional information (if necessary may also be
reported on page 2)
Les informations complémentaires (si nécessaire,,
peuvent être indiqués sur la 2^{ème} page

Additionally evaluated to EN 60950-1: 2006 / A11: 2009 / A1:
2010 / A12: 2011 / A2:2013; National Differences specified in the
CB Test Report

A sample of the product was tested and found
to be in conformity with
Un échantillon de ce produit a été essayé et a été
considéré conforme à la

Additional Information on page 2
IEC 60950-1(ed.2), IEC 60950-1(ed.2);am1, IEC 60950-
1(ed.2);am2

As shown in the Test Report Ref. No. which forms
part of this Certificate
Comme indiqué dans le Rapport d'essais numéro de
référence qui constitue partie de ce Certificat

E125496-A18-CB-1 issued on 2016-05-31

This CB Test Certificate is issued by the National Certification Body
Ce Certificat d'essai OC est établi par l'Organisme **National de Certification**



- UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA
- UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK
- UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN
- UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA

For full legal entity names see www.ul.com/nbcnames

Date: 2016-05-31
Original Issue Date: 2015-02-05

Signature:

Jan-Erik Storgaard

Factories:

Global Scanning Suzhou Co Ltd
Building 39, Dongjing Industrial Zone
No. 9 Dongfu Road
Suzhou Industrial Park
Suzhou, 215123 Jiangsu China

Additional Information:

The original report was modified to include the following changes/additions:

- 1) 2 scanners model TL53D and TM53D was added to report.
- 2) 2 stands Type SD One MF 36 Low Stand and Type SD One MF 24 Low Stand were added to the report as optional accessories.
- 3) New factory Global Scanning Suzhou Co Ltd was added
- 4) Applicant, manufacturer and factory names changed to GLOBAL SCANNING A/S

Additional information (if necessary)

Information complémentaire (si nécessaire)



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